

N-Channel RF Amplifier

This device is designed primarily for electronic switching applications such as low On Resistance analog switching. Sourced from Process 50.

Absolute Maximum Ratings* TA = 25°C unless otherwise noted

| Symbol | Parameter | Value | Units |
|-----------------|--|-------------|-------|
| V _{DG} | Drain-Gate Voltage | 25 | V |
| V _{GS} | Gate-Source Voltage | - 25 | V |
| I _{GF} | Forward Gate Current | 10 | mA |
| T_{J},T_{stg} | Operating and Storage Junction Temperature Range | -55 to +150 | °C |

*These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

<u>NOTES</u>: 1) These ratings are based on a maximum junction temperature of 150 degrees C.

2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

Thermal Characteristics TA = 25°C unless otherwise noted

| Symbol | Characteristic | Мах | | Units |
|------------------|---|-------------|----------------|-------|
| | | 2N5484-5486 | *MMBF5484-5486 | |
| PD | Total Device Dissipation | 350 | 225 | mW |
| | Derate above 25°C | 2.8 | 1.8 | mW/°C |
| R _{eJC} | Thermal Resistance, Junction to Case | 125 | | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | 357 | 556 | °C/W |

*Device mounted on FR-4 PCB 1.6" X 1.6" X 0.06."

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N-Channel RF Amplifier (continued)

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|----------------------|----------------------------------|---|----------------|-----|-------|--------------|
| | RACTERISTICS | | | | | |
| | Gate-Source Breakdown Voltage | | - 25 | | | V |
| IGSS | Gate Reverse Current | $I_G = -1.0 \ \mu A, V_{DS} = 0$ $V_{GS} = -20 \ V, V_{DS} = 0$ | - 25 | | - 1.0 | nA |
| IGSS | Gate Reverse Current | | | | - 0.2 | μΑ |
| V _{GS(off)} | Gate-Source Cutoff Voltage | $\begin{array}{c} V_{\text{GS}}\text{=-20 V}, V_{\text{DS}}\text{=0}, T_{\text{A}}\text{=100}^{\circ}\text{C} \\ V_{\text{DS}}\text{=15 V}, I_{\text{D}}\text{=10 nA} \textbf{5484} \end{array}$ | - 0.3 | | - 3.0 | V |
| | | 5485 5486 | - 0.5 - 2.0 | | - 4.0 | |
| | | 5460 | - 2.0 | | - 0.0 | v |
| ON CHAR | ACTERISTICS | | | | | |
| | Zero-Gate Voltage Drain Current* | V _{DS} = 15 V, V _{GS} = 0 5484 | 1.0 | | 5.0 | mA |
| 033 | Zore outo voltage brain ourient | 5485 | 4.0 | | 10 | mA |
| | | 5486 | 8.0 | | 20 | mA |
| | GNAL CHARACTERISTICS | V _{DS} = 15 V, V _{GS} = 0, f = 1.0 kHz | | | | |
| 9fs | Forward Transfer Conductance | 5484 | 3000 | | 6000 | μmho |
| | | 5485 | 3500 | | 7000 | μmho |
| | land Operaturations | 5486 | 4000 | | 8000 | μmho |
| Re(Yis) | Input Conductance | V _{DS} = 15 V, V _{GS} = 0, f = 100 MHz 5484 | | | 100 | μmho |
| | | $V_{DS} = 15 \text{ V}, V_{GS} = 0, \text{ f} = 400 \text{ MHz}$ | | | 100 | μπιο |
| | | 5485 / 5486 | | | 1000 | μmho |
| gos | Output Conductance | V _{DS} = 15 V, V _{GS} = 0, f = 1.0 kHz 5484 | | | 50 | umbo |
| | | 5484 | | | 60 | µmho µmho |
| | | 5486 | | | 75 | μmho |
| Re(yos) | Output Conductance | V _{DS} = 15 V, V _{GS} = 0, f = 100 MHz | | | 75 | |
| | | 5484 V _{DS} = 15 V, V _{GS} = 0, f = 400 MHz | | | 75 | μmho |
| | | 5485 / 5486 | | | 100 | μmho |
| Re(Yfs) | Forward Transconductance | V _{DS} = 15 V, V _{GS} = 0, f = 100 MHz | | | | |
| | | 5484 V _{DS} = 15 V, V _{GS} = 0, f = 400 MHz | 2500 | | | μmho |
| | | 5485 | 3000 | | | μmho |
| | | 5486 | 3500 | | | μmho |
| Ciss | Input Capacitance | $V_{DS} = 15 V, V_{GS} = 0, f = 1.0 MHz$ | | | 5.0 | pF |
| Crss | Reverse Transfer Capacitance | V _{DS} = 15 V, V _{GS} = 0, f = 1.0 MHz | | | 1.0 | pF |
| Coss | Output Capacitance | $V_{DS} = 15 V, V_{GS} = 0, f = 1.0 MHz$ | | | 2.0 | pF |
| NF | Noise Figure | V_{DS} = 15 V, R _G = 1.0 kΩ, f = 100 MHz 5484 | | | 3.0 | dB |
| | | V _{DS} = 15 V, R _G = 1.0 kΩ, f = 400 MHz 5484 | | 4.0 | | dB |
| | | V_{DS} = 15 V , R_{G} = 1.0 k Ω , | | | 2.0 | -10 |
| | | f = 100 MHz 5485 / 5486 | | | 2.0 | dB |
| | | V_{DS} = 15 V, R_{G} = 1.0 k Ω , | 1 | 1 | 4.0 | dB |

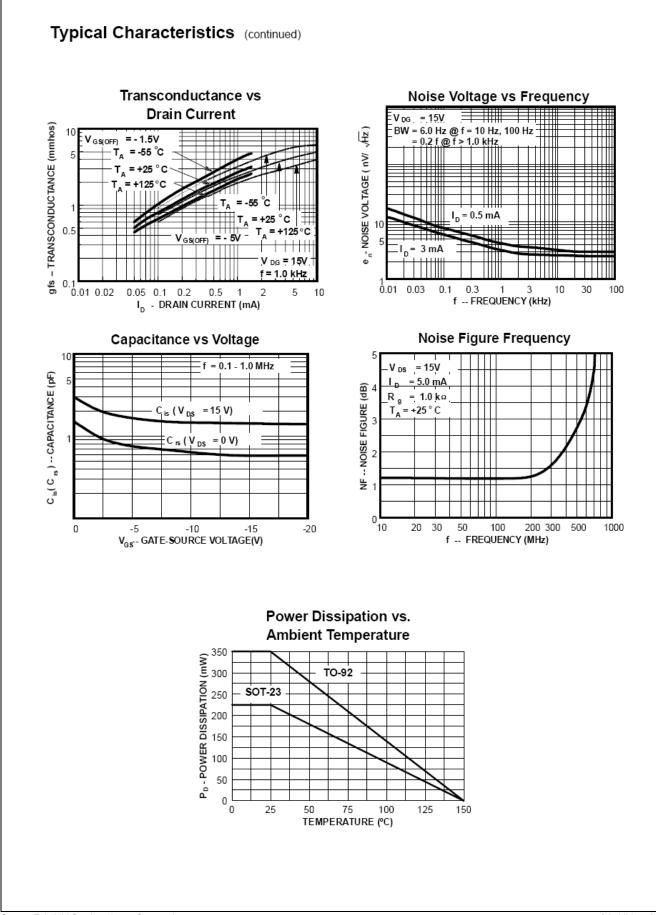
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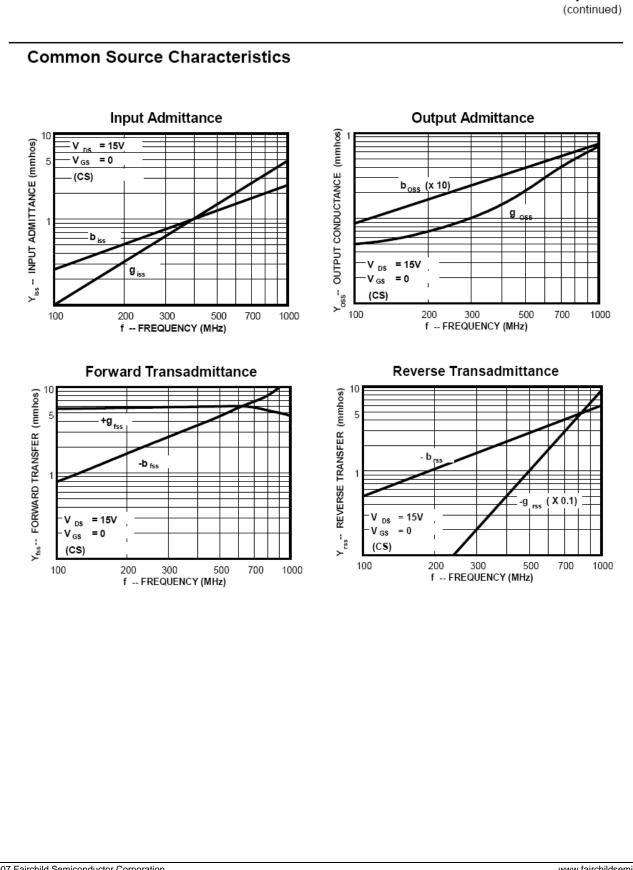
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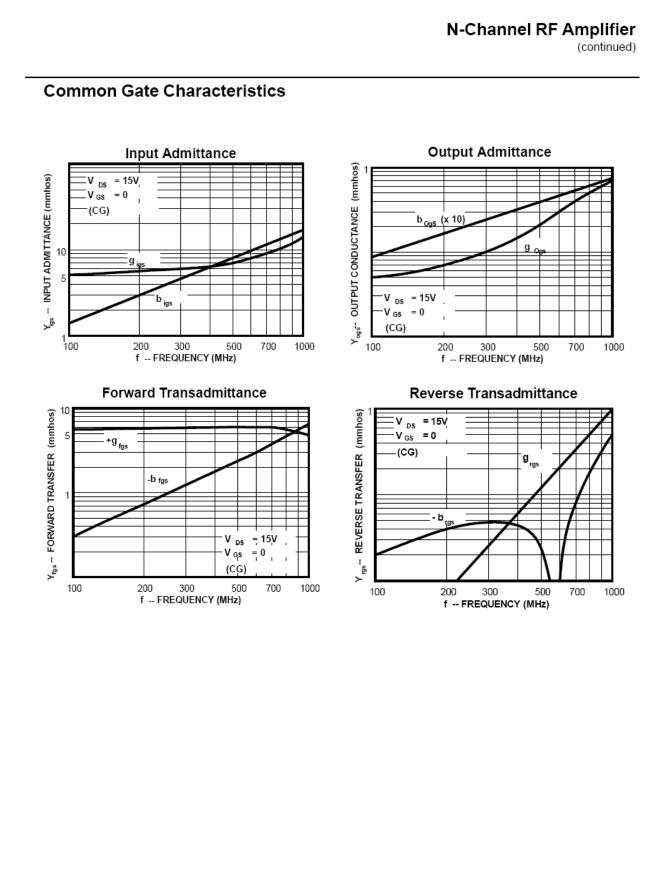
Typical Characteristics Transfer Characteristics **Channel Resistance vs Temperature** 20 1000 -4.5V V GS(OFF) = 15V r_{DS} - DRAIN ON RESISTANCE (Ω) 500 = -55°C T_A -1.0V V_{GS(QFF)} 1(DRAIN CURRENT (mA) 300 = +25 ° C -2.5 V 200 +125° C 12 = -55°C -5.0V TA 100 Τ<u>A</u> = +25 ° C -8.0 V TA +125° C 50 30 ė = 100mV V_{,DS} 20 = 0 V 25 V ν 0 10 0 -2 -4 -5 -50 0 50 100 150 -3 -1 V_{gs}- GATE-SOURCE VOLTAGE(V) TA - AMBIENT TEMPERATURE (C) Common Drain-Source Transconductance Characteristics Characteristics -- TRANSCONDUCTANCE (mmhos) -5 V _{DS} = -55 °C = 15V T_A = +25 ° C I D--- DRAIN CURRENT (mA) = +25 ° C 6 ТҮР v = -5.0V Δ GS(OFF) 2.0V = +125° C 5 0 = -55 °C TA 2 5V 3 = +25 ° C . Т_ 3.0V = +125° C т, 2 3.5V 2 -4.5\ GS(OFF) = 4.0V -2.5 V 0 sf 0 0 0.2 0.4 0.6 0.8 0 1 -3 -1 -2 -4 -5 V_{DS} - DRAIN-SOURCE VOLTAGE(V) V_{gs} GATE-SOURCE VOLTAGE(V) **Output Conductance vs** Transconductance Drain Current Parameter Interactions -- OUTPUT CONDUCTANCE (u mhos) -- DRAIN "ON" RESISTANCE (Ω) 02 gfs, I_{DSS} $P_{SS} @ V_{DS} = 15 V, V_{GS} = 0 PULSE$ $r_{DS} @ V_{DS} = 100mV, V_{GS} = 0$ = +25 °C DRAIN CURRENT (mA) -5.5V 1.0 kHz 5.0\ 20 10V 15V 10 10 5 20\ 20 ν = -3.5V GS(OFF) DSS-- | 0.5 -1.5V @ V_{GS}= 15V, I _D= 1nA V_{GS(OFF)} GS(OFF) ÷ ළී 10 0.1 1 gos . sfg - 2 -3 - 5 0.05 0.1 0.2 0.5 - 7 - 10 1 2 5 10 V GS - GATE-SOURCE VOLTAGE(V) I D-- DRAIN CURRENT (mA)

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